

December 2007

FDMC8678S

N-Channel Power Trench[®] SyncFETTM 30V, 18A, 5.2m Ω

Features

- Max $r_{DS(on)} = 5.2m\Omega$ at $V_{GS} = 10V$, $I_D = 15A$
- Max $r_{DS(on)} = 8.7 \text{m}\Omega$ at $V_{GS} = 4.5 \text{V}$, $I_D = 12 \text{A}$
- Advanced Package and Silicon combination for low r_{DS(on)} and high efficiency
- SyncFET Schottky Body Diode
- MSL1 robust package design
- RoHS Compliant



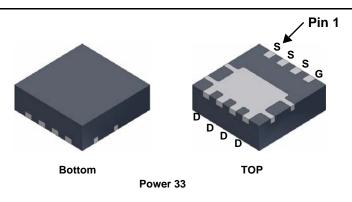
General Description

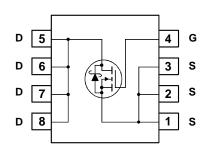
The FDMC8678S has been designed to minimize losses in power conversion applications. Advancements in both silicon and package technologies have been combined to offer the lowest $r_{DS(on)}$ while maintaining excellent switching performance. This device has the added benefit of an efficient monolithic Schottky body diode.

Applications

Synchronous Rectifier for DC/DC Converters

- Notebook Vcore/ GPU low side switch
- Networking Point of Load low side switch
- Telecom secondary side rectification





MOSFET Maximum Ratings T_A = 25°C unless otherwise noted

Symbol	Parameter			Ratings	Units
V_{DS}	Drain to Source Voltage			30	V
V_{GS}	Gate to Source Voltage			±20	V
	Drain Current -Continuous (Package limited)	T _C = 25°C		18	
I _D	-Continuous (Silicon limited)	T _C = 25°C		66	A
	-Continuous	T _A = 25°C	(Note 1a)	15	A
	-Pulsed			60	
E _{AS}	Single Pulse Avalanche Energy		(Note 3)	181	mJ
Б	Power Dissipation	T _C = 25°C		41	W
P_{D}	Power Dissipation	T _A = 25°C	(Note 1a)	2.3	VV
T _J , T _{STG}	Operating and Storage Junction Temperature Range			-55 to +150	°C

Thermal Characteristics

$R_{\theta JC}$	Thermal Resistance, Junction to Case	3	°C/W
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient (Note 1a	53	C/VV

Package Marking and Ordering Information

Device Marking	Device	Package	Reel Size	Tape Width	Quantity
8678S	FDMC8678S	Power 33	13"	12 mm	3000 units

Units

Max

Electrical Characteristics $T_J = 25$ °C unless otherwise noted Parameter

Off Char	acteristics					
BV_{DSS}	Drain to Source Breakdown Voltage	$I_D = 1 \text{mA}, V_{GS} = 0 \text{V}$	30			V
$\frac{\Delta BV_{DSS}}{\Delta T_{J}}$	Breakdown Voltage Temperature Coefficient	I _D = 1mA, referenced to 25°C		38		mV/°C
I _{DSS}	Zero Gate Voltage Drain Current	$V_{GS} = 0V, V_{DS} = 24V,$			500	μΑ
I _{GSS}	Gate to Source Leakage Current	$V_{GS} = \pm 20V, V_{DS} = 0V$			±100	nA

Test Conditions

Min

On Characteristics

Symbol

$V_{GS(th)}$	Gate to Source Threshold Voltage	$V_{GS} = V_{DS}$, $I_D = 1mA$	1	1.9	3	V
$\frac{\Delta V_{GS(th)}}{\Delta T_J}$	Gate to Source Threshold Voltage Temperature Coefficient	I _D = 1mA, referenced to 25°C		-3.7		mV/°C
		$V_{GS} = 10V, I_D = 15A$		4.3	5.2	
r _{DS(on)}	Static Drain to Source On Resistance	$V_{GS} = 4.5V, I_D = 12A$		6.3	8.7	mΩ
		$V_{GS} = 10V, I_D = 15A, T_J = 125$ °C		6	10	
g _{FS}	Forward Transconductance	$V_{DD} = 10V, I_D = 15A$		55		S

Dynamic Characteristics

C _{iss}	Input Capacitance	V 45V V 0V		1560	2075	pF
C _{oss}	Output Capacitance	$V_{DS} = 15V, V_{GS} = 0V,$ f = 1MHz		810	1080	pF
C _{rss}	Reverse Transfer Capacitance	1 - 11/11/2		90	135	pF
R_g	Gate Resistance	f = 1MHz		0.8		Ω

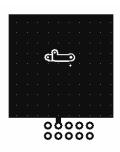
Switching Characteristics

t _{d(on)}	Turn-On Delay Time			11	20	ns
t _r	Rise Time	$V_{DD} = 15V, I_D = 15A,$		3	10	ns
t _{d(off)}	Turn-Off Delay Time	$V_{GS} = 10V, R_{GEN} = 6\Omega$		24	39	ns
t _f	Fall Time			2	10	ns
Qg	Total Gate Charge	V _{GS} =0Vto10V		24	34	nC
Qg	Total Gate Charge	$V_{GS} = 0V \text{ to } 4.5V$ $V_{DD} = 15V,$		11	16	nC
Q _{gs}	Gate to Source Charge	I _D = 15A		4.7		nC
Q _{ad}	Gate to Drain "Miller" Charge			2.8		nC

Drain-Source Diode Characteristics

V_{SD}	Source to Drain Diode Forward Voltage	$V_{GS} = 0V, I_{S} = 3A$	(Note 2)		0.5	0.7	V
t _{rr}	Reverse Recovery Time	I _E = 15A, di/dt = 300A/μs			31	51	ns
Q _{rr}	Reverse Recovery Charge	T _F = 15A, αl/αt = 300A/μs		33	51	nC	

1. R_{0JA} is determined with the device mounted on a 1in² pad 2 oz copper pad on a 1.5 x 1.5 in. board of FR-4 material. R_{0JC} is guaranteed by design while R_{0CA} is determined by the user's board design.



a. 53°C/W when mounted on a 1 in² pad of 2 oz copper



b. 125°C/W when mounted on a minimum pad of 2 oz copper

- 2. Pulse Test: Pulse Width < $300\mu\text{s},$ Duty cycle < 2.0%.
- 3. Starting $T_J = 25^{\circ}C$; N-ch: L = 3mH, $I_{AS} = 11A$, $V_{DD} = 30V$, $V_{GS} = 10V$

Typical Characteristics T_J = 25°C unless otherwise noted

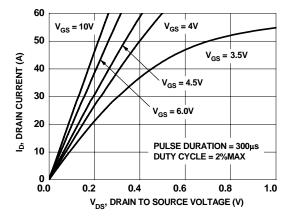


Figure 1. On-Region Characteristics

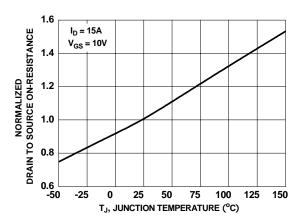


Figure 3. Normalized On-Resistance vs Junction Temperature

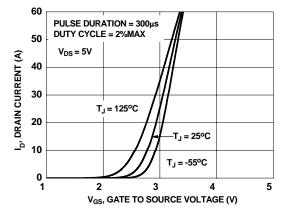


Figure 5. Transfer Characteristics

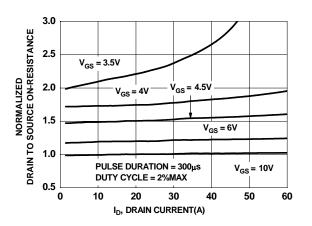


Figure 2. Normalized On-Resistance vs Drain Current and Gate Voltage

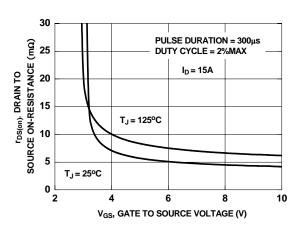


Figure 4. On-Resistance vs Gate to Source Voltage

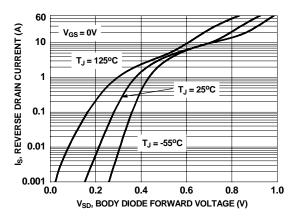


Figure 6. Source to Drain Diode Forward Voltage vs Source Current

Typical Characteristics T_J = 25°C unless otherwise noted

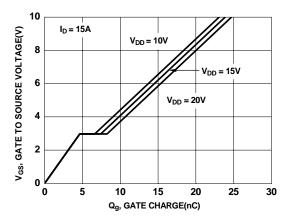


Figure 7. Gate Charge Characteristics

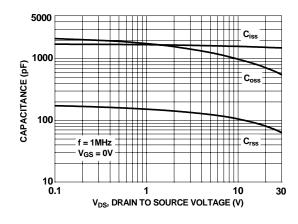


Figure 8. Capacitance vs Drain to Source Voltage

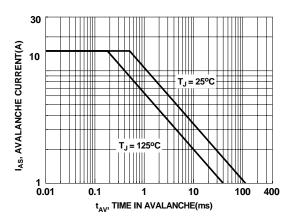


Figure 9. Unclamped Inductive Switching Capability

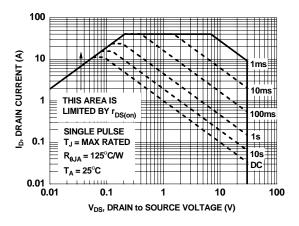


Figure 10. Forward Bias Safe Operating Area

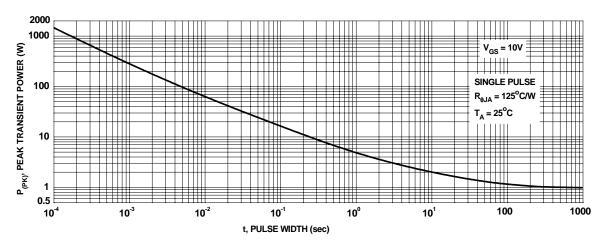


Figure 11. Single Pulse Maximum Power Dissipation

Typical Characteristics T_J = 25°C unless otherwise noted

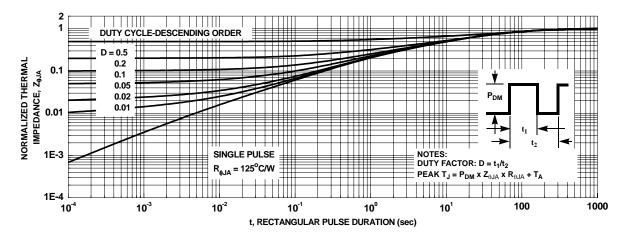


Figure 12. Transient Thermal Response Curve

Typical Characteristics (continued)

SyncFET Schottky body diode Characteristics

Fairchild's SyncFET process embeds a Schottky diode in parallel with PowerTrench MoSFET. This diode exhibits similar characteristics to a discrete external Schottky diode in parallel with a MOSFET. Figure 14 shows the reverses recovery characteristic of the FDMC8678S.

Schottky barrier diodes exhibit significant leakage at high temperature and high reverse voltage. This will increase the power in the device.

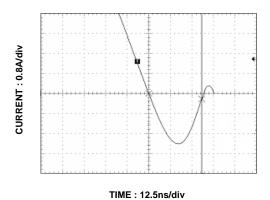


Figure 13. SyncFET body diode reverse recovery characteristic

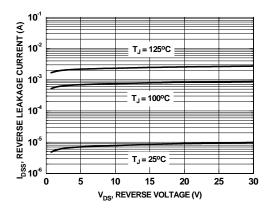
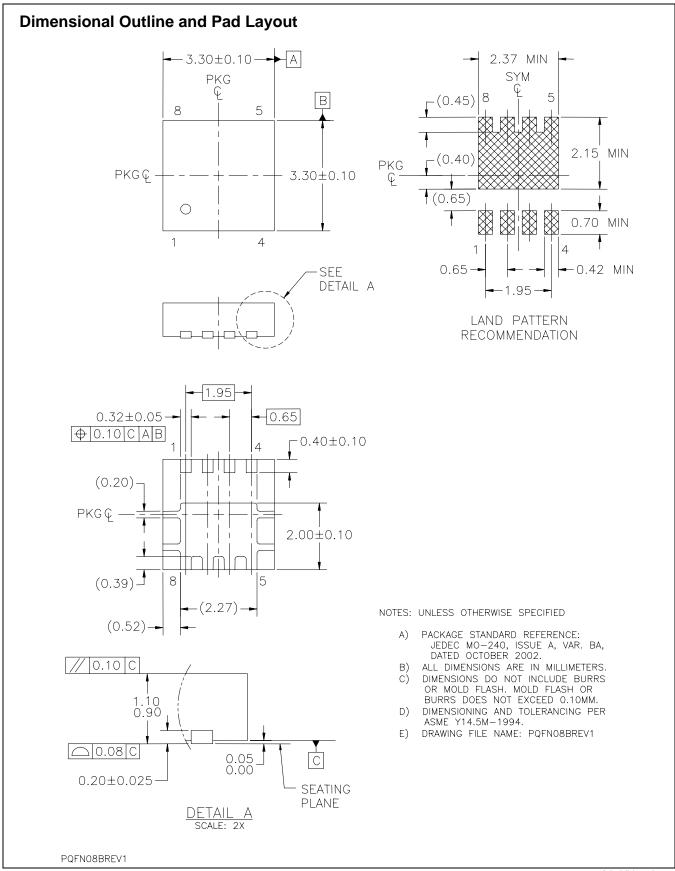


Figure 14. SyncFET body diode reverses leakage versus drain-source voltage





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